Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
09/675,992	LEE ET AL.	
Examiner	Art Unit	
Lena Najarian	3626	

SEARCHED					
Class	Subclass	Date	Examiner		
709	203	7/6/2005	LN		
705	10 35 38	7/6/2005	LN		
· 706	21	7/6/2005	LN		
715	700	7/6/2005	LN		
705	26	7/7/2005	LN		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East (see attached printout) USPAT;US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	7/6/2005	LN		
East (see attached printout) USPAT;US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	7/7/2005	LN		
East (see attached printout) USPAT;US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	7/8/2005	LN		
JSTOR (see attached printout)	7/8/2005	LN		
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